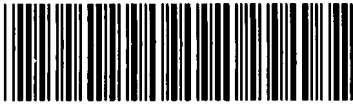


**Search Notes**

Application/Control No.

10/829,386

Examiner

Henok G. Heyi

Applicant(s)/Patent under  
Reexamination

AN ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
369	275.1	11/19/2007	HH
720	719	11/19/2007	HH
720	722	11/19/2007	HH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched.	11/19/2007	HH